

# UNISONIC TECHNOLOGIES CO., LTD

4N70-S Preliminary Power MOSFET

# 4A, 700V N-CHANNEL POWER MOSFET

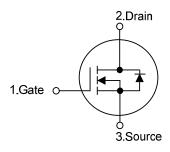
#### ■ DESCRIPTION

The UTC **4N70-S** is a high voltage power MOSFET and is designed to have better characteristics, such as fast switching time, low gate charge, low on-state resistance and high rugged avalanche. This high speed switching power MOSFET is usually used in power supplies, PWM motor controls, high efficient DC to DC converters and bridge circuits.

#### ■ FEATURES

- \*  $R_{DS(ON)}$  < 3.2  $\Omega$  @ $V_{GS}$  = 10 V,  $I_{D}$ =2A
- \* Fast Switching Capability
- \* Avalanche Energy Specified
- \* Improved dv/dt Capability, High Ruggedness

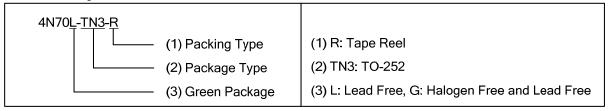
#### ■ SYMBOL



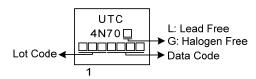
#### ORDERING INFORMATION

Ordering Number		Doolsone	Pin .	Assignr	Doolsing	
Lead Free	Halogen Free	Package	1	2	3	Packing
4N70L-TN3-R	4N70G-TN3-R	TO-252	G	D	S	Tape Reel

Note: Pin Assignment: G: Gate D: Drain S: Source



#### MARKING



1 TO-252

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### ■ ABSOLUTE MAXIMUM RATINGS (T<sub>A</sub> = 25°C, unless otherwise specified)

PAR	AMETER	SYMBOL	RATINGS	UNIT	
Drain-Source Voltage		$V_{DSS}$	700	V	
Gate-Source Voltage		$V_{GSS}$	±30	V	
Desir Ourse	Continuous	I <sub>D</sub>	4	Α	
Drain Current	Pulsed (Note 2)	I <sub>DM</sub>	16	Α	
Avalanche Energy	valanche Energy Single Pulsed (Note 3)		135	mJ	
Peak Diode Recovery dv/dt (Note 4)		dv/dt	4.5	V/ns	
Power Dissipation		$P_{D}$	49	W	
Junction Temperature		TJ	+150	°C	
Operating Temperature		T <sub>OPR</sub>	-55 ~ <b>+</b> 150	°C	
Storage Temperature		T <sub>STG</sub>	-55 ~ +150	°C	

Notes: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged.

Absolute maximum ratings are stress ratings only and functional device operation is not implied.

- 2. Repetitive Rating : Pulse width limited by maximum junction temperature
- 3. L = 16.87mH,  $I_{AS}$  = 4A,  $V_{DD}$  = 50V,  $R_G$  = 25  $\Omega$ , Starting  $T_J$  = 25°C
- 4.  $I_{SD} \le 4A$ , di/dt  $\le 200A/\mu s$ ,  $V_{DD} \le BV_{DSS}$ , Starting  $T_J = 25$ °C

#### ■ THERMAL DATA

PARAMETER	SYMBOL	RATINGS	UNIT	
Junction to Ambient	$\theta_{JA}$	110	°C/W	
Junction to Case	θјς	2.55	°C/W	

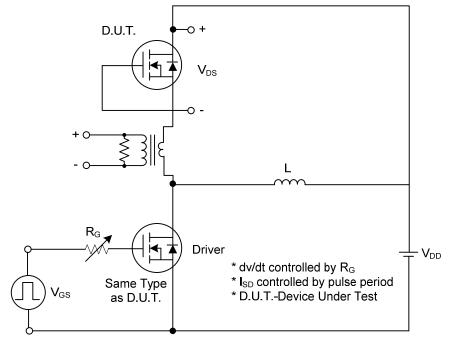
## ■ ELECTRICAL CHARACTERISTICS (T<sub>A</sub>=25°C, unless otherwise specified)

PARAMETER		SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
OFF CHARACTERISTICS							
Drain-Source Breakdown Voltage		BV <sub>DSS</sub>	V <sub>GS</sub> = 0 V, I <sub>D</sub> = 250 μA	700			V
Drain-Source Leakage Current		I <sub>DSS</sub>	V <sub>DS</sub> = 700 V, V <sub>GS</sub> = 0 V			10	μA
Cata Cauraa I aaka aa Currant	Forward	I <sub>GSS</sub>	$V_{GS} = 30 \text{ V}, V_{DS} = 0 \text{ V}$			100	^
Gate-Source Leakage Current	Reverse		$V_{GS} = -30 \text{ V}, V_{DS} = 0 \text{ V}$			-100	nA
Breakdown Voltage Temperature Coefficient		$\triangle BV_{DSS}/\triangle T_{J}$	$I_D$ = 250µA, Referenced to 25°C		0.6		V/°C
ON CHARACTERISTICS							
Gate Threshold Voltage		$V_{GS(TH)}$	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$			4.0	V
Static Drain-Source On-State Res	sistance	R <sub>DS(ON)</sub>	$V_{GS} = 10 \text{ V}, I_D = 2 \text{ A}$			3.2	Ω
DYNAMIC CHARACTERISTICS							
Input Capacitance		C <sub>ISS</sub>	.,		450	575	pF
Output Capacitance		Coss	$V_{DS} = 25 \text{ V}, V_{GS} = 0 \text{ V},$ f = 1MHz		48	70	pF
Reverse Transfer Capacitance		$C_{RSS}$			4	8	pF
SWITCHING CHARACTERISTIC	S						
Turn-On Delay Time Turn-On Rise Time		$t_{D(ON)}$	$V_{DD} = 30V, I_D = 0.5A,$ $R_G = 25\Omega \text{ (Note 1, 2)}$		60		ns
		$t_R$			18		ns
Turn-Off Delay Time		t <sub>D(OFF)</sub>			92		ns
Turn-Off Fall Time	-Off Fall Time				15		ns
Total Gate Charge		$Q_{G}$	50/1 404		13.8	20	nC
Gate-Source Charge		$Q_GS$	V <sub>DS</sub> = 50V, I <sub>D</sub> = 1.3A, -V <sub>GS</sub> = 10 V (Note 1, 2)		5		nC
Gate-Drain Charge		$Q_GD$			1.4		nC
SOURCE- DRAIN DIODE RATIN	GS AND CI	HARACTERIST	TICS		ā.	-	
Drain-Source Diode Forward Volt	age	$V_{SD}$	$V_{GS} = 0 \text{ V}, I_{S} = 4 \text{ A}$			1.4	V
Maximum Continuous Drain-Source Diode		Is				4	Α
Forward Current						4	Α
Maximum Pulsed Drain-Source Diode Forward Current		I <sub>SM</sub>				16	Α
						10	_ ^

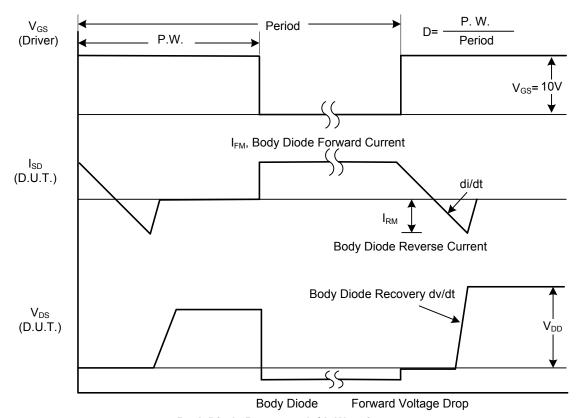
Notes: 1. Pulse Test: Pulse width ≤ 300µs, Duty cycle ≤ 2%

<sup>2.</sup> Essentially independent of operating temperature

### **TEST CIRCUITS AND WAVEFORMS**

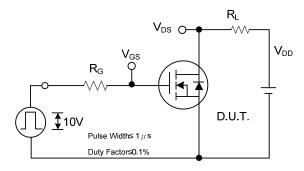


Peak Diode Recovery dv/dt Test Circuit

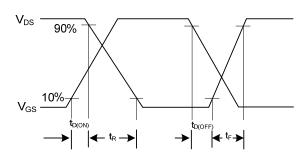


Peak Diode Recovery dv/dt Waveforms

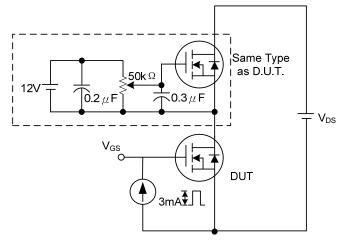
■ TEST CIRCUITS AND WAVEFORMS (Cont.)



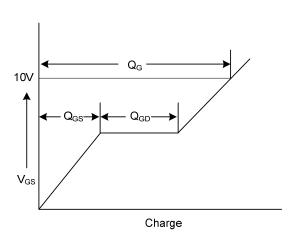
**Switching Test Circuit** 



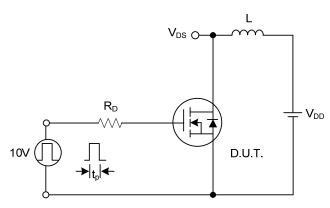
**Switching Waveforms** 



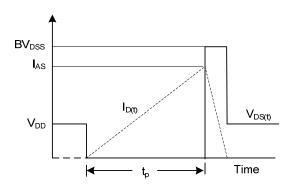
**Gate Charge Test Circuit** 



**Gate Charge Waveform** 



**Unclamped Inductive Switching Test Circuit** 



**Unclamped Inductive Switching Waveforms** 

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